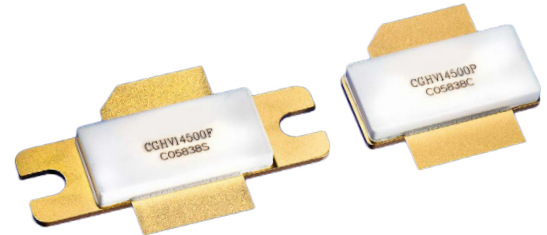


CGHV14500F

500 W, DC - 1800 MHz, GaN HEMT
for L-Band Radar Systems

Description

The CGHV14500 is a gallium nitride (GaN) high electron mobility transistor (HEMT) designed specifically with high efficiency, high gain and wide bandwidth capabilities, which makes the CGHV14500 ideal for DC - 1.8 GHz L-Band radar amplifier applications. The transistor could be utilized for band specific applications ranging from 800 through 1600 MHz. The package options are ceramic/metal flange and pill package.



Package Types: 440117, 440133
PNs: CGHV14500F, CGHV14500P

Typical Performance Over 1.2 - 1.4 GHz ($T_c = 25^\circ\text{C}$) of Demonstration Amplifier

Parameter	1.2 GHz	1.25 GHz	1.3 GHz	1.35 GHz	1.4 GHz	Units
Outdoor Power	545	540	530	530	530	W
Gain	16.4	16.3	16.2	16.2	16.2	dB
Drain Efficiency	69	69	68	66	65	%

Note: Measured in the CGHV14500-AMP amplifier circuit, under 500 μs pulse width, 10% duty cycle, PIN = 41 dBm.

Features

- Reference design amplifier 1.2 - 1.4 GHz Operation
- FET tuning range UHF through 1800 MHz
- 500 W Typical Output Power
- 16 dB Power Gain
- 68% Typical Drain Efficiency
- <0.3 dB Pulsed Amplitude Droop
- Internally pre-matched on input, unmatched output



Large Signal Models Available for ADS and MWO



Absolute Maximum Ratings (not simultaneous)

Parameter	Symbol	Rating	Units	Conditions
Drain-Source Voltage	V_{DS}	150	V	25°C
Gate-to-Source Voltage	V_{GS}	-10, +2		
Storage Temperature	T_{STG}	-65, +150	°C	
Operating Junction Temperature	T_J	225		
Maximum Forward Gate Current	I_{GMAX}	84	mA	25°C
Maximum Drain Current ¹	I_{DMAX}	36	A	
Soldering Temperature ²	T_S	245	°C	
Screw Torque	τ	40	in-oz	
Pulsed Thermal Resistance, Junction to Case ³	$R_{\theta JC}$	0.28	°C/W	$P_{DISS} = 334 \text{ W}, 500 \mu\text{sec}, 10\%, 85^\circ\text{C}$
Pulsed Thermal Resistance, Junction to Case ⁴		0.31		
Case Operating Temperature ⁵	T_C	-40, +130	°C	$P_{DISS} = 334 \text{ W}, 500 \mu\text{sec}, 10\%$

Notes:

¹ Current limit for long term, reliable operation² Refer to the Application Note on soldering³ Measured for the CGHV14500P⁴ Measured for the CGHV14500F⁵ See also, the Power Dissipation De-rating Curve on Page 16

Electrical Characteristics ($T_C = 25^\circ\text{C}$)

Parameter	Symbol	Min.	Typ.	Max.	Units	Conditions
DC Characteristics¹						
Gate Threshold Voltage	$V_{GS(th)}$	-3.8	-3.0	-2.3	V_{DC}	$V_{DS} = 10 \text{ V}, I_D = 83.6 \text{ mA}$
Gate Quiescent Voltage	$V_{GS(Q)}$	—	-2.7	—		$V_{DS} = 50 \text{ V}, I_D = 500 \text{ mA}$
Saturated Drain Current ²	I_{DS}	54.3	77.7	—	A	$V_{DS} = 6.0 \text{ V}, V_{GS} = 2.0 \text{ V}$
Drain-Source Breakdown Voltage	V_{BR}	125	—	—	V_{DC}	$V_{GS} = -8 \text{ V}, I_D = 83.6 \text{ mA}$
RF Characteristics³ ($T_C = 25^\circ\text{C}$, $F_0 = 1.4 \text{ GHz}$ unless otherwise noted)						
Output Power	P_{OUT}	400	500	—	W	$V_{DD} = 50 \text{ V}, I_{DQ} = 500 \text{ mA}, P_{IN} = 41 \text{ dBm}$
Drain Efficiency	D_E	60	68	—	%	
Power Gain	G_P	15.25	16.2	—	dB	$V_{DD} = 50 \text{ V}, I_{DQ} = 500 \text{ mA}$
Pulsed Amplitude Droop	D	—	-0.3	—		
Output Mismatch Stress	VSWR	—	5 : 1	—	Y	No damage at all phase angles, $V_{DD} = 50 \text{ V}$, $I_{DQ} = 500 \text{ mA}, P_{IN} = 41 \text{ dBm}$ Pulsed
Dynamic Characteristics						
Input Capacitance	C_{GS}	—	295	—	pF	$V_{DS} = 50 \text{ V}, V_{GS} = -8 \text{ V}, f = 1 \text{ MHz}$
Output Capacitance	C_{DS}	—	27	—		
Feedback Capacitance	C_{GD}	—	2.7	—		

Notes:

¹ Measured on wafer prior to packaging² Scaled from PCM data³ Measured in CGHV14500-AMP. Pulsed Width = 500 μs , Duty Cycle = 10%.

Typical Performance of the CGHV14500F

Test conditions unless otherwise noted: $V_{DD} = 50\text{ V}$, $I_{DQ} = 500\text{ mA}$, $PW = 500\text{ }\mu\text{s}$, $DC = 10\%$, $P_{IN} = 42\text{ dBm}$, $T_{BASE} = +25^\circ\text{C}$

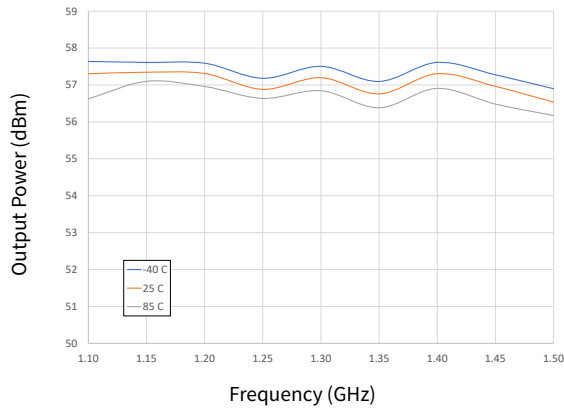


Figure 1. Output Power vs Frequency as a Function of Temperature

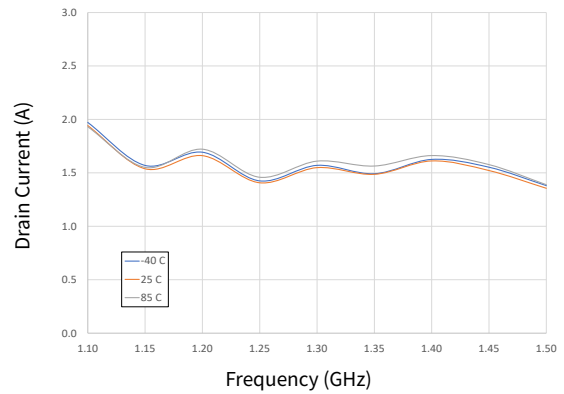


Figure 2. Drain Current vs Frequency as a Function of Temperature

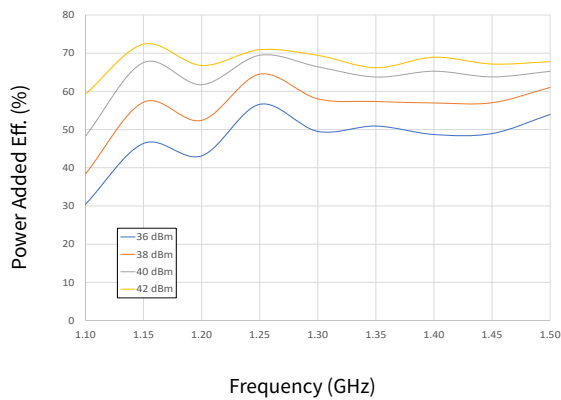


Figure 3. Power Added Eff. vs Frequency as a Function of Input Power

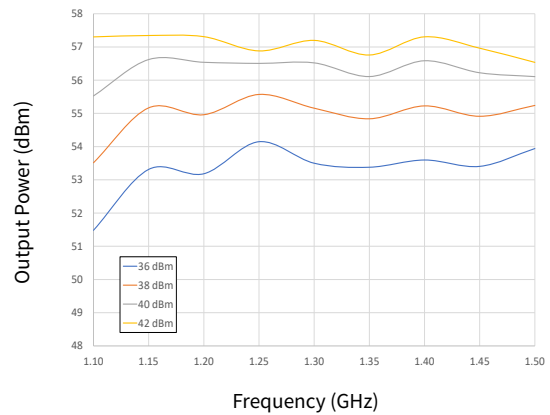


Figure 4. Output Power vs Frequency as a Function of Input Power

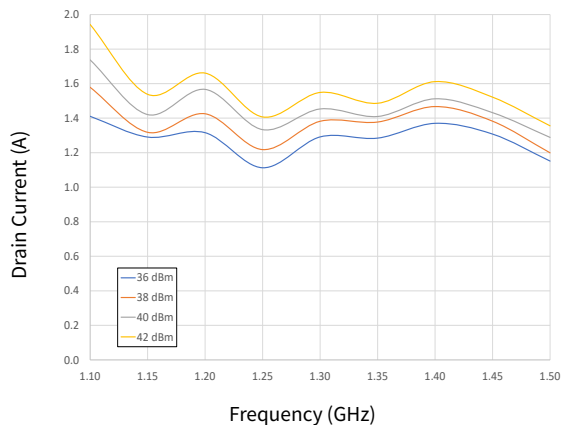


Figure 5. Drain Current vs Frequency as a Function of Input Power

Typical Performance of the CGHV14500F

Test conditions unless otherwise noted: $V_{DD} = 50\text{ V}$, $I_{DQ} = 500\text{ mA}$, $PW = 500\text{ }\mu\text{s}$, $DC = 10\%$, $P_{IN} = 42\text{ dBm}$, $T_{BASE} = +25^\circ\text{C}$

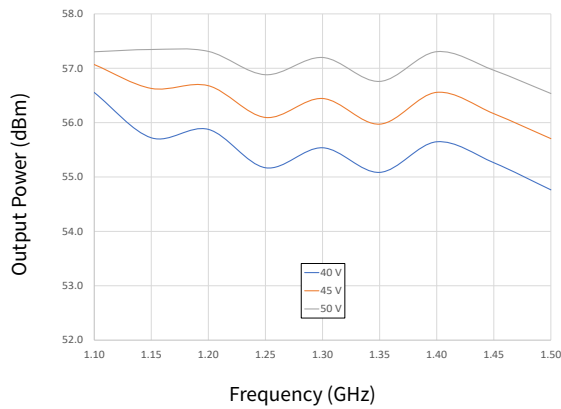


Figure 6. Output Power vs Frequency as a Function of Voltage

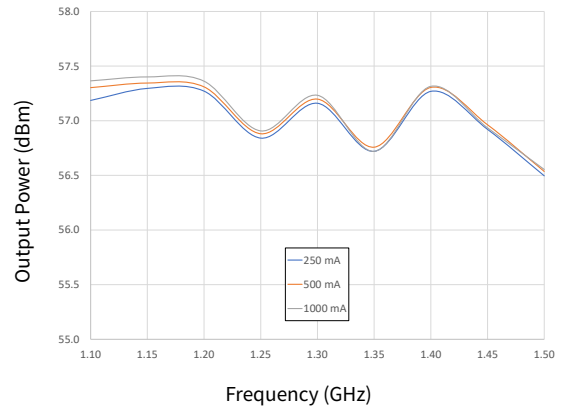


Figure 7. Output Power vs Frequency as a Function of I_{DQ}

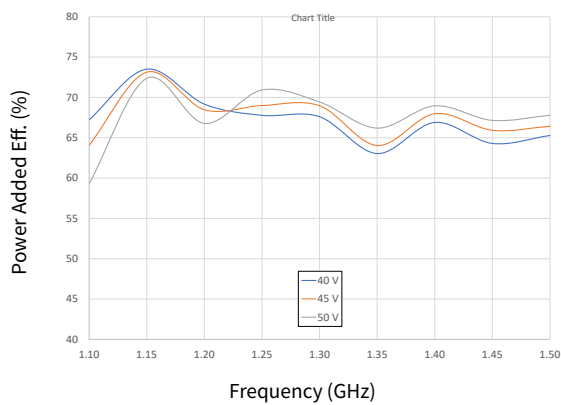


Figure 8. Power Added Eff. vs Frequency as a Function of Voltage

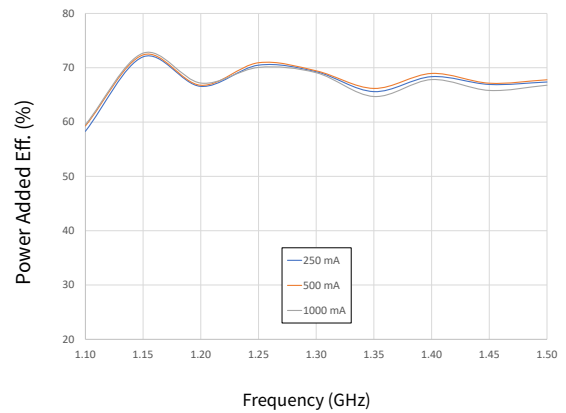


Figure 9. Power Added Eff. vs Frequency as a Function of I_{DQ}

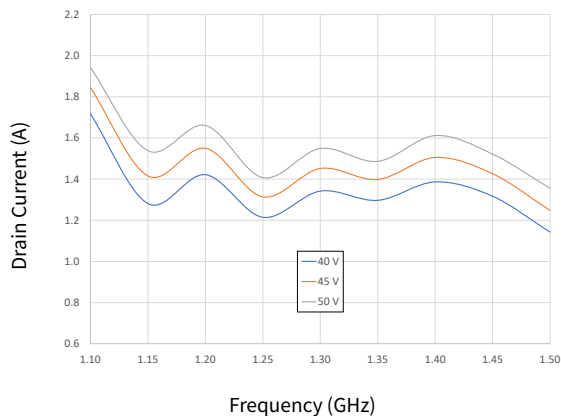


Figure 10. Drain Current vs Frequency as a Function of Voltage

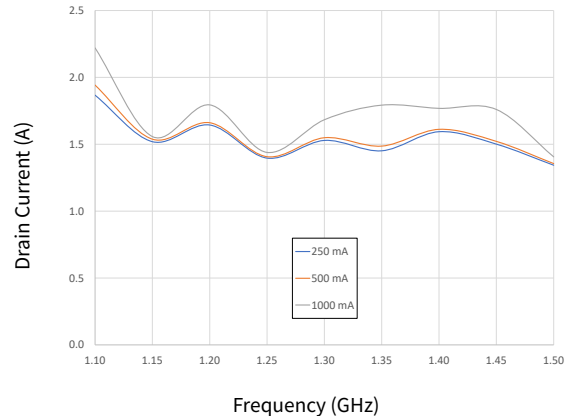


Figure 11. Drain Current vs Frequency as a Function of I_{DQ}

Typical Performance of the CGHV14500F

Test conditions unless otherwise noted: $V_{DD} = 50\text{ V}$, $I_{DQ} = 500\text{ mA}$, $PW = 500\text{ }\mu\text{s}$, $DC = 10\%$, $P_{IN} = 42\text{ dBm}$, $T_{BASE} = +25^\circ\text{C}$

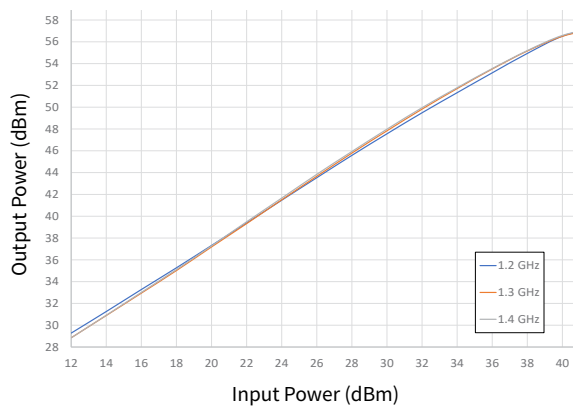


Figure 12. Output Power vs Input Power as a Function of Frequency

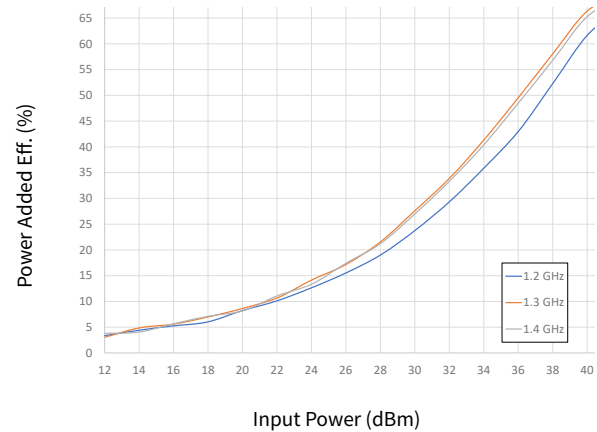


Figure 13. Power Added Eff. vs Input Power as a Function of Frequency

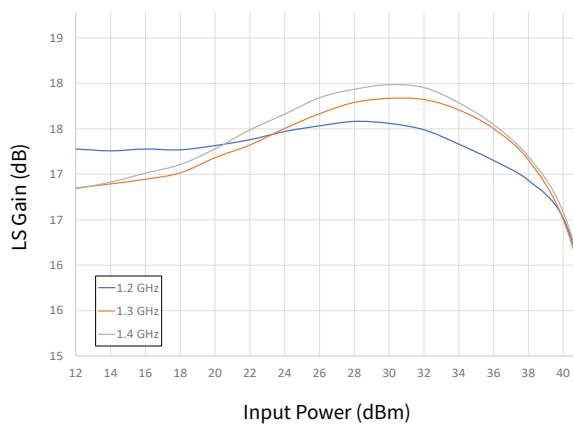


Figure 14. Large Signal Gain vs Input Power as a Function of Frequency

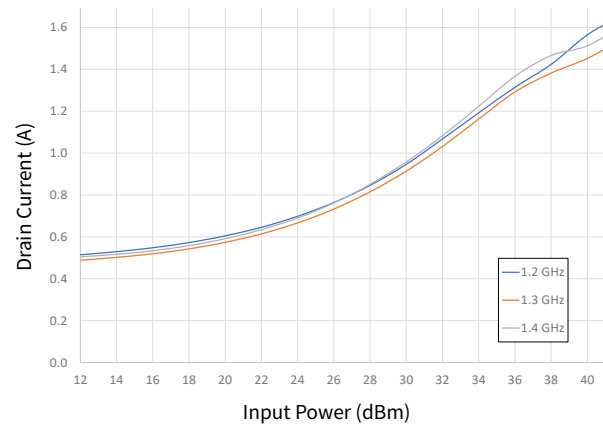


Figure 15. Drain Current vs Input Power as a Function of Frequency

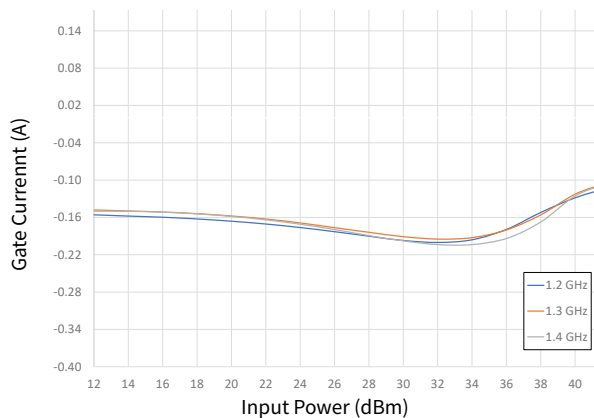


Figure 16. Gate Current vs Input Power as a Function of Frequency

Typical Performance of the CGHV14500F

Test conditions unless otherwise noted: $V_{DD} = 50\text{ V}$, $I_{DQ} = 500\text{ mA}$, $PW = 500\text{ }\mu\text{s}$, $DC = 10\%$, $P_{IN} = 42\text{ dBm}$, $T_{BASE} = +25\text{ }^{\circ}\text{C}$

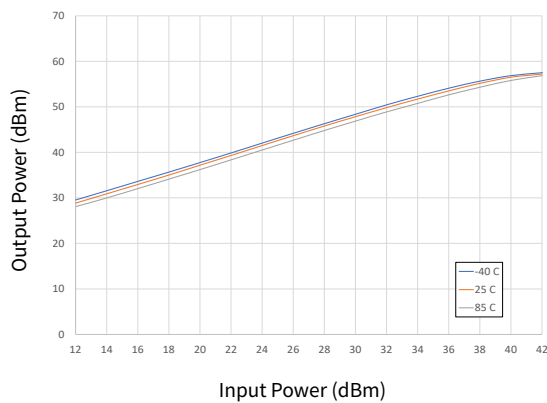


Figure 17. Output Power vs Input Power as a Function of Temperature

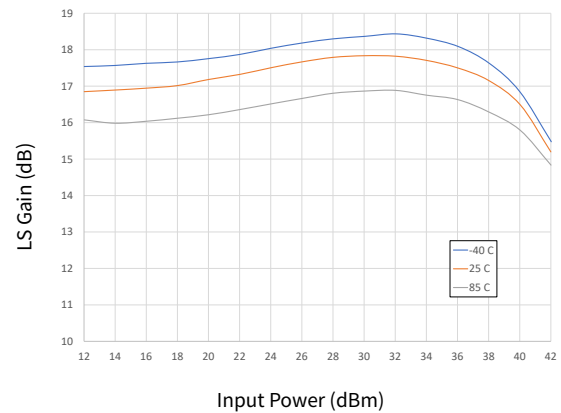


Figure 18. Large Signal Gain vs Input Power as a Function of Temperature

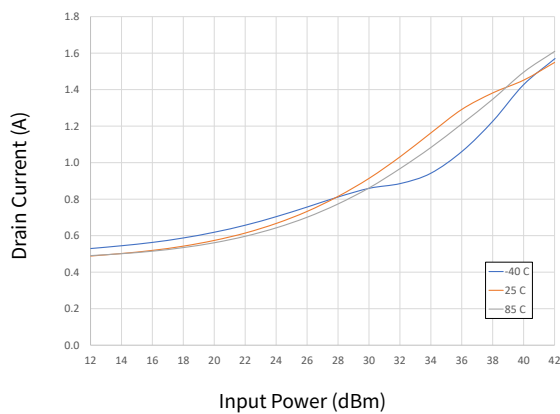


Figure 19. Drain Current vs Input Power as a Function of Temperature

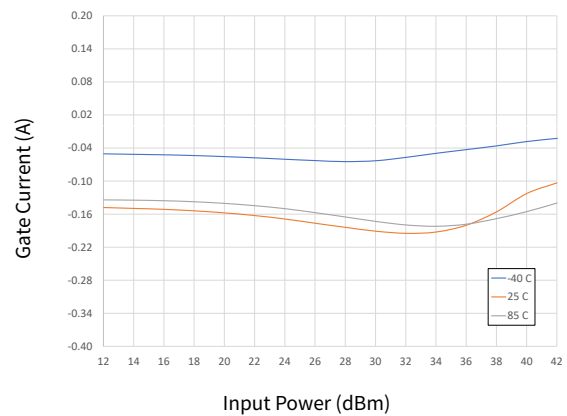


Figure 20. Gate Current vs Input Power as a Function of Temperature

Typical Performance of the CGHV14500F

Test conditions unless otherwise noted: $V_{DD} = 50\text{ V}$, $I_{DQ} = 500\text{ mA}$, $PW = 500\text{ }\mu\text{s}$, $DC = 10\%$, $P_{IN} = 42\text{ dBm}$, $T_{BASE} = +25^\circ\text{C}$

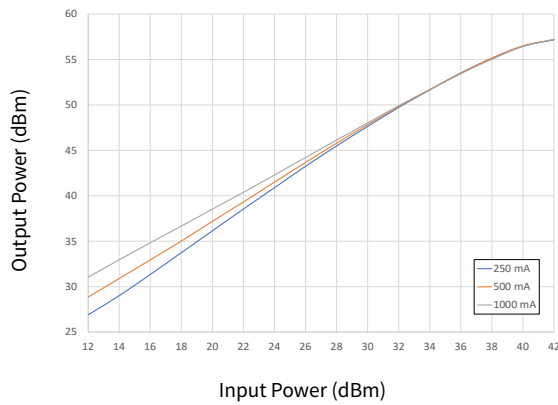


Figure 21. Output Power vs Input Power as a Function of I_{DQ}

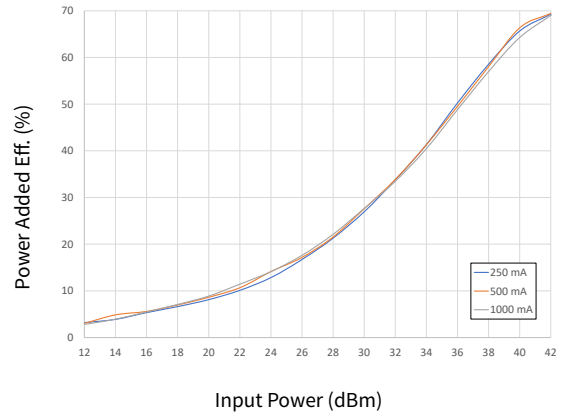


Figure 22. Power Added Eff. vs Input Power as a Function of I_{DQ}

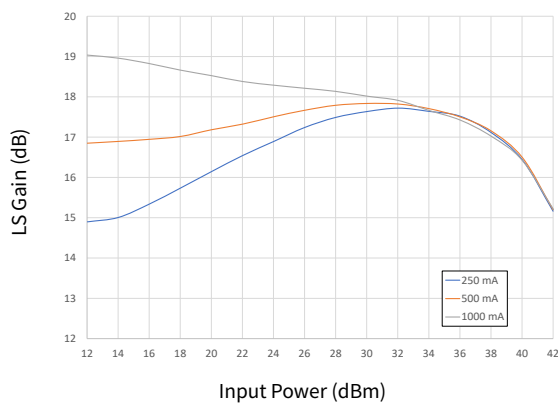


Figure 23. Large Signal Gain vs Input Power as a Function of I_{DQ}

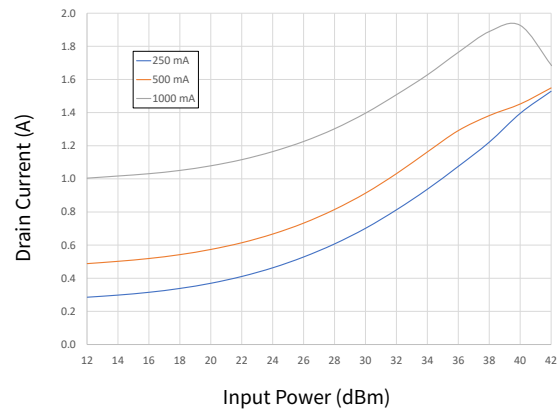


Figure 24. Drain Current vs Input Power as a Function of I_{DQ}

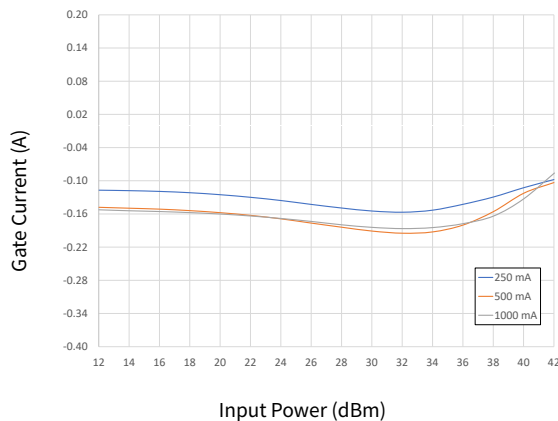


Figure 25. Gate Current vs Input Power as a Function of I_{DQ}

Typical Performance of the CGHV14500F

Test conditions unless otherwise noted: $V_{DD} = 50\text{ V}$, $I_{DQ} = 500\text{ mA}$, CW, $P_{IN} = -20\text{ dBm}$, $T_{BASE} = +25^\circ\text{C}$

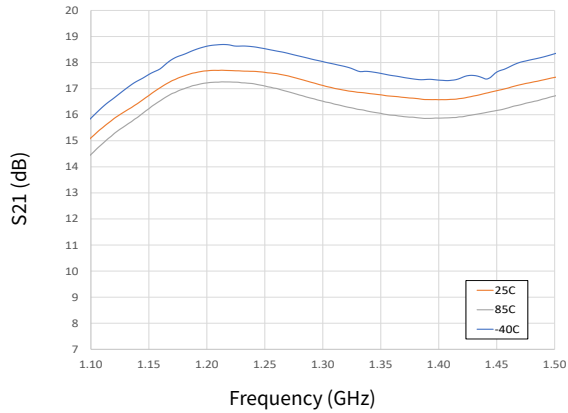


Figure 26. Gain vs Frequency as a Function of Temperature

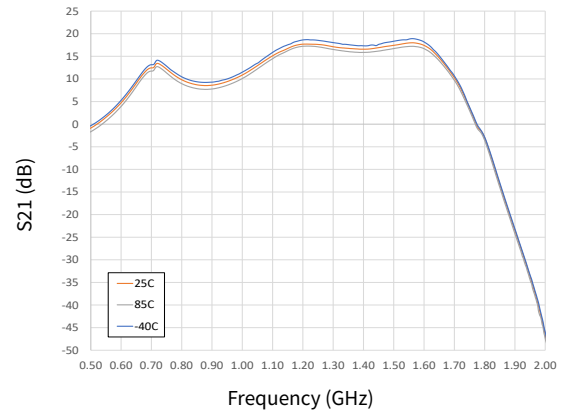


Figure 27. Gain vs Frequency as a Function of Temperature

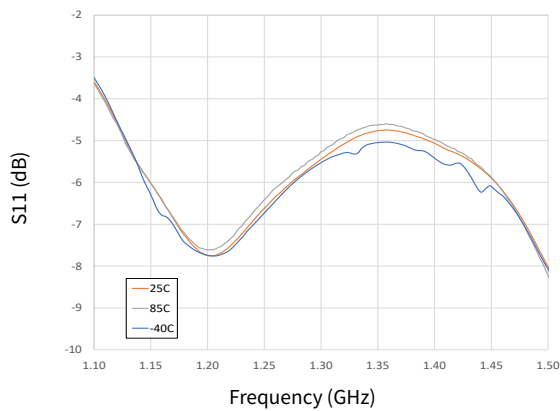


Figure 28. Input RL vs Frequency as a Function of Temperature

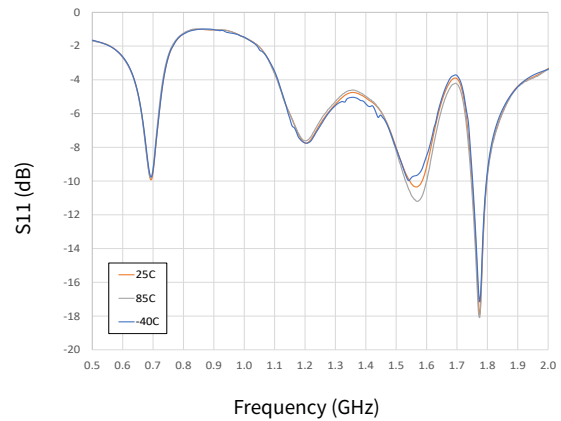


Figure 29. Input RL vs Frequency as a Function of Temperature

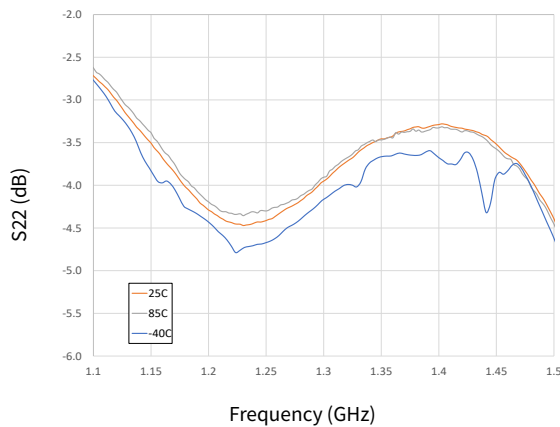


Figure 30. Output RL vs Frequency as a Function of Temperature

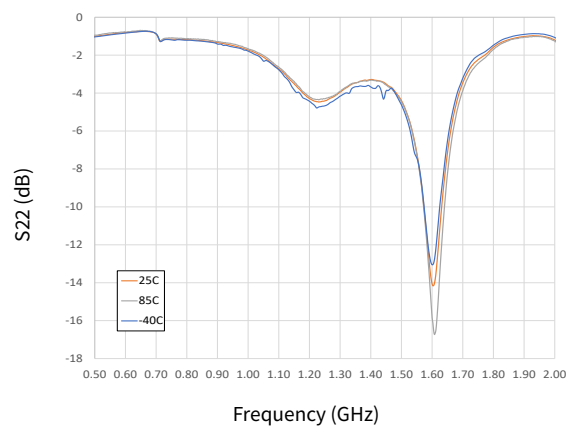


Figure 31. Output RL vs Frequency as a Function of Temperature

Typical Performance of the CGHV14500F

Test conditions unless otherwise noted: $V_{DD} = 50\text{ V}$, $I_{DQ} = 500\text{ mA}$, CW, $P_{IN} = -20\text{ dBm}$, $T_{BASE} = +25^\circ\text{C}$

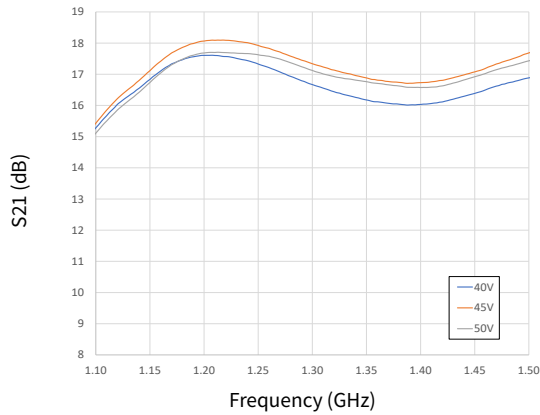


Figure 32. Gain vs Frequency as a Function of Voltage

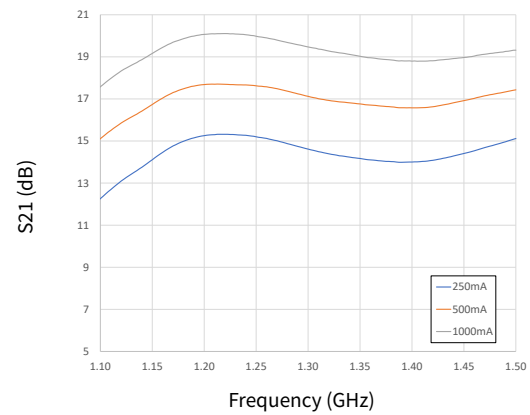


Figure 33. Gain vs Frequency as a Function of I_{DQ}

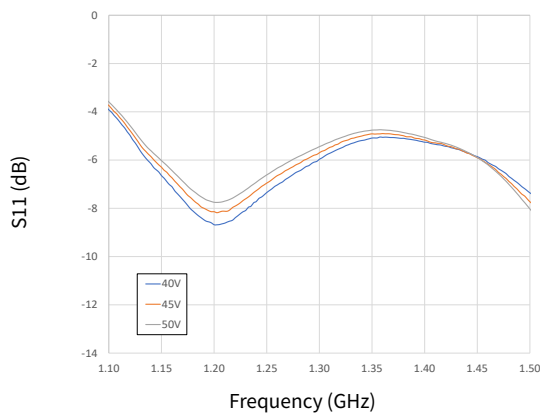


Figure 34. Input RL vs Frequency as a Function of Voltage

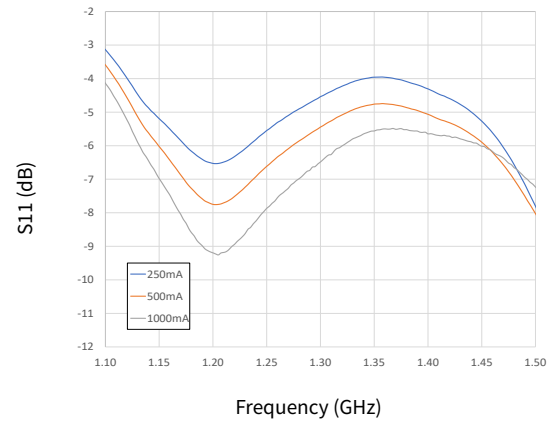


Figure 35. Input RL vs Frequency as a Function of I_{DQ}

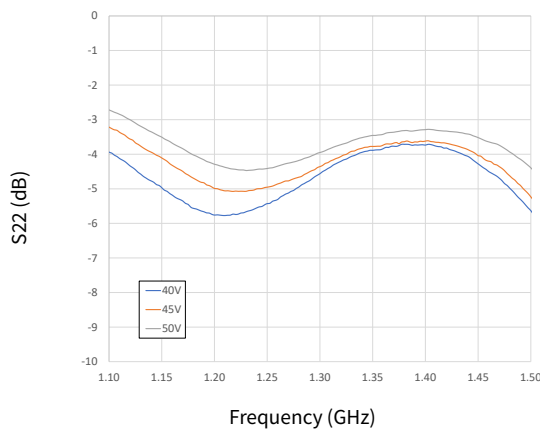


Figure 36. Output RL vs Frequency as a Function of Voltage

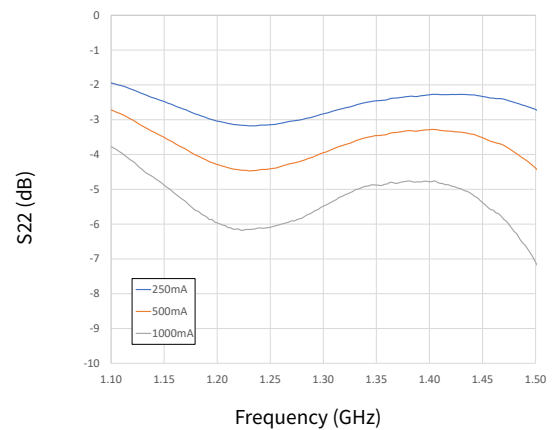
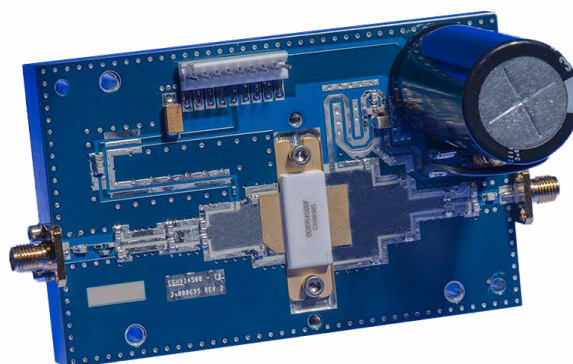


Figure 37. Output RL vs Frequency as a Function of I_{DQ}

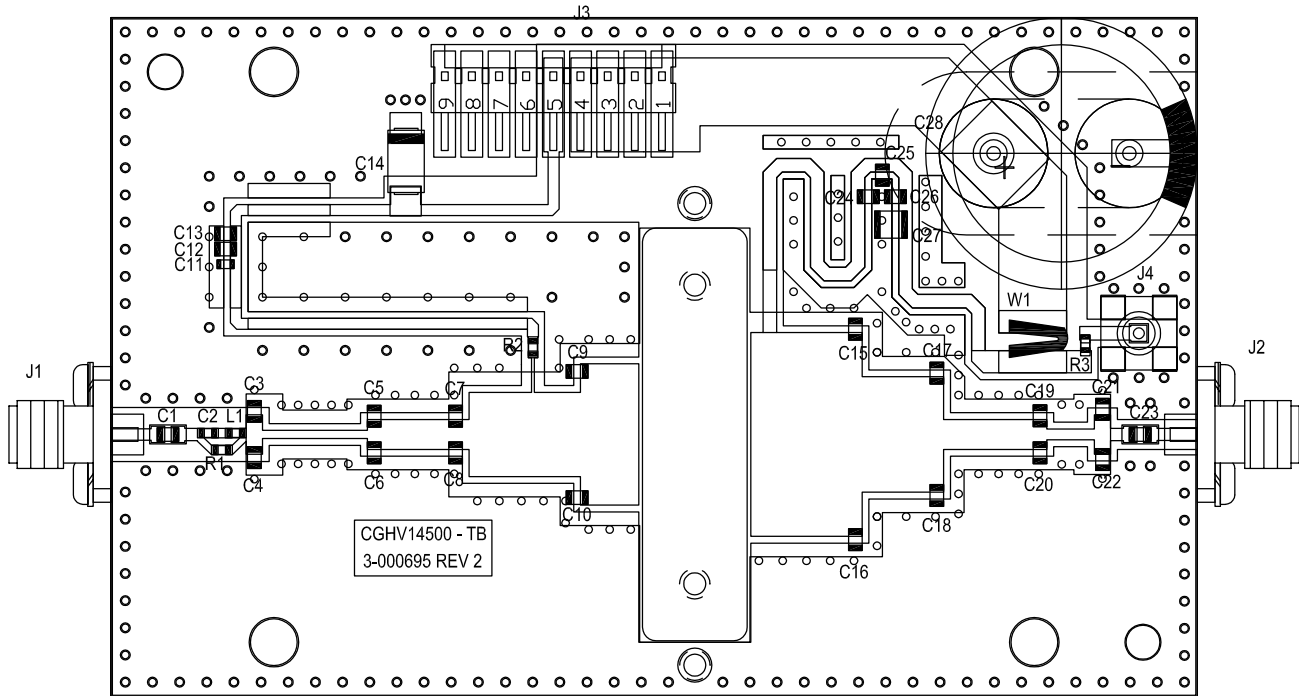
CGHV14500F-AMP Demonstration Amplifier Circuit Bill of Materials

Designator	Description	Qty
R1	RES, 1/16W, 0603, 1%, 562 ohms	1
R2	RES, 5.1 ohm, +/-1%, 1/16W, 0603	1
R3	RES, 1/16W, 0603, 1%, 4700 ohms	1
L1	INDUCTOR, CHIP, 6.8 nH, 0603 SMT	1
C1, C23	CAP, 27pF, +/- 5%, 250V, 0805, ATC 600F	2
C2	CAP, 2.0pF, +/- 0.1pF, 0603, ATC	1
C3, C4	CAP, 1.5pF, +/-0.05pF, 250V, 0805, ATC 600F	2
C5,C6	CAP, 1.8pF, +/-0.1pF, 250V, 0805, ATC 600F	2
C7,C8	CAP, 4.3pF, +/-0.1pF, 250V, 0805, ATC 600F	2
C9,C10	CAP, 7.5pF, +/-0.1pF, 250V, 0805, ATC 600F	2
C11,C24	CAP, 47pF,+/-5%, 250V, 0805, ATC 600F	2
C12,C25	CAP, 100pF, +/-5%, 250V, 0805, ATC 600F	2
C13,C26	CAP, 33000pF, 0805, 100V, X7R	2
C14	CAP, 10μF, 16V, TANTALUM	1
C15,C16	CAP, 5.6pF, +/-0.1pF, 250V, 0805, ATC 600F	2
C17,C18	CAP, 3.6pF, +/-0.1pF, 250V, 0805, ATC 600F	2
C19,C20	CAP, 2.0pF, +/-0.1pF, 250V, 0805, ATC 600F	2
C21,C22	CAP, 0.7pF, +/-0.05pF, 0805, ATC 600F	2
C27	CAP, 1.0μF, 100V, 10%, X7R, 1210	1
C28	CAP, 3300 μF, +/-20%, 100V, ELECTROLYTIC	1
J1,J2	CONN, SMA, PANEL MOUNT JACK, FL	2
J3	HEADER RT>PLZ .1CEN LK 9POS	1
J4	CONNECTOR ; SMB, Straight, JACK, SMD	1
W1	CABLE, 18 AWG, 4.2	1
	PCB, RO4350B, 0.020' MIL THK, CGHV14500, 1.2-1.4GHZ	1
Q1	CGHV14500F	1

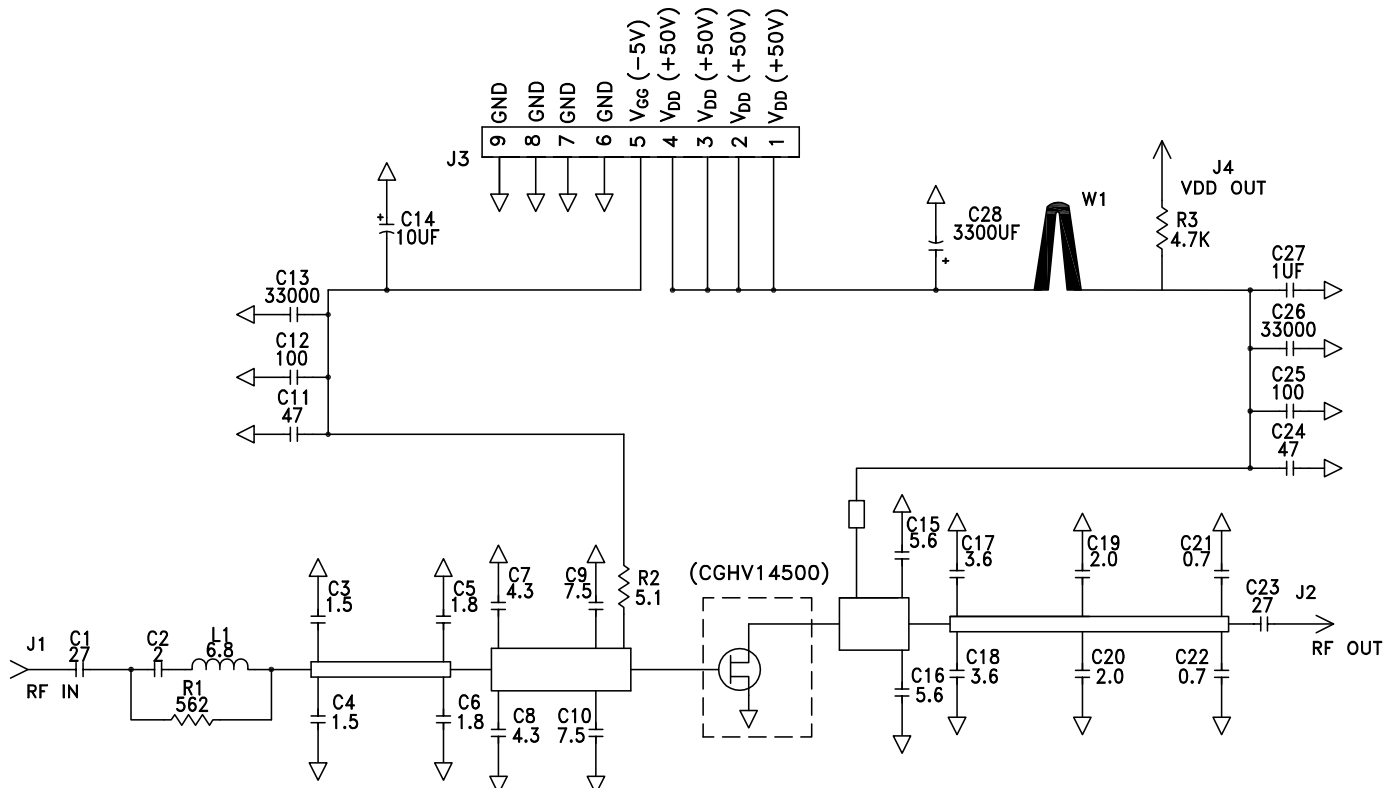
CGHV14500F-AMP Demonstration Amplifier Circuit



CGHV14500-AMP Demonstration Amplifier Circuit Outline



CGHV14500-AMP Demonstration Amplifier Circuit Schematic



Typical Performance Over 0.96 GHz - 1.3 GHz ($T_c = 25^{\circ}\text{C}$) of Demonstration Amplifier

Parameter	0.96 GHz	1.0 GHz	1.1 GHz	1.2 GHz	1.3 GHz	Units
Output Power	800	805	675	625	585	W
Gain	18	18.1	17.3	17.0	16.7	dB
Drain Efficiency	70	75	74	77	64	%

Note: Measured in the CGHV14500-AMP2 amplifier circuit, under 500 μs pulse width, 10% duty cycle, $P_{IN} = 41\text{ dBm}$.

Typical Performance - CGHV14500-AMP2

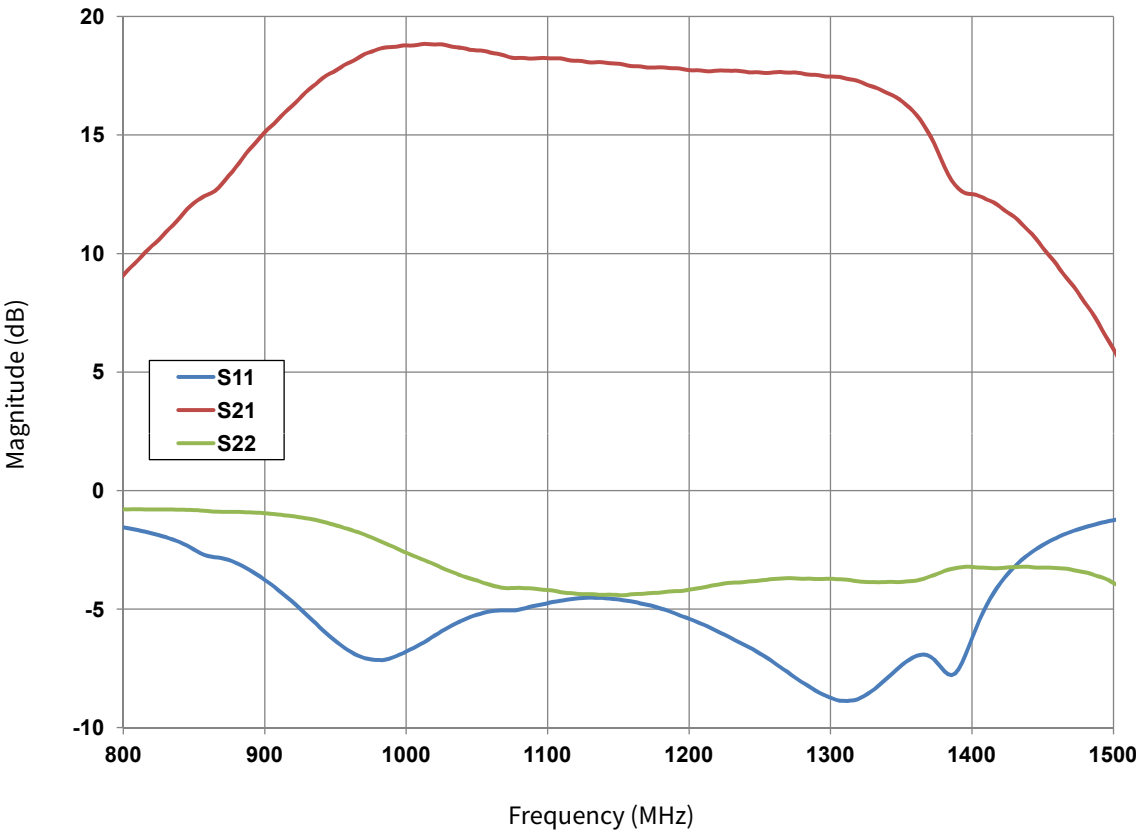


Figure 1. CGHV14500-AMP2 Typical S Parameters
 $V_{DD} = 50\text{ V}$, $I_{DQ} = 500\text{ mA}$

Typical Performance - CGHV14500-AMP2

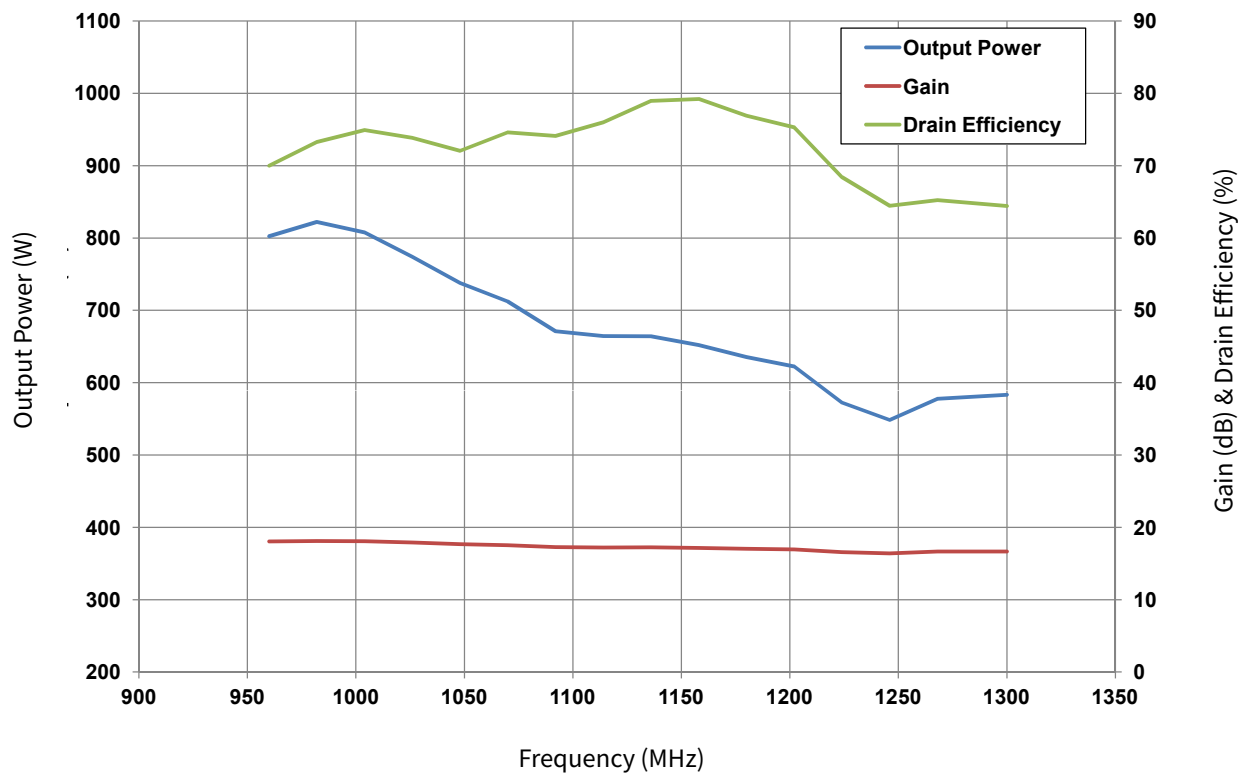


Figure 2. CGHV14500-AMP2 Typical S Parameters
 $V_{DD} = 50\text{ V}$, $I_{DQ} = 500\text{ mA}$, $P_{IN} = 41\text{ dBm}$, Pulse Width = $500\text{ }\mu\text{s}$, Duty Cycle 10%

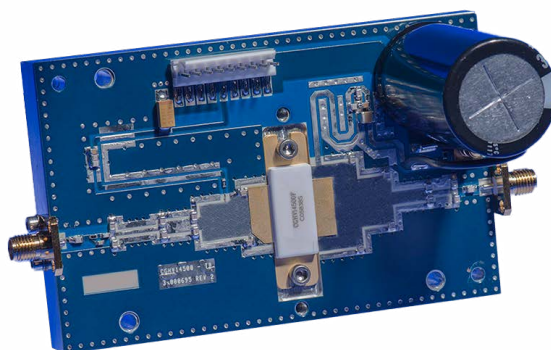
Electrostatic Discharge (ESD) Classifications

Parameter	Symbol	Class	Classification Level	Test Methodology
Human Body Model	HBM	TBD	ANSI/ESDA/JEDEC JS-001 Table 3	JEDEC JESD22 A114-D
Charge Device Model	CDM	TBD	ANSI/ESDA/JEDEC JS-002 Table 3	JEDEC JESD22 C101-C

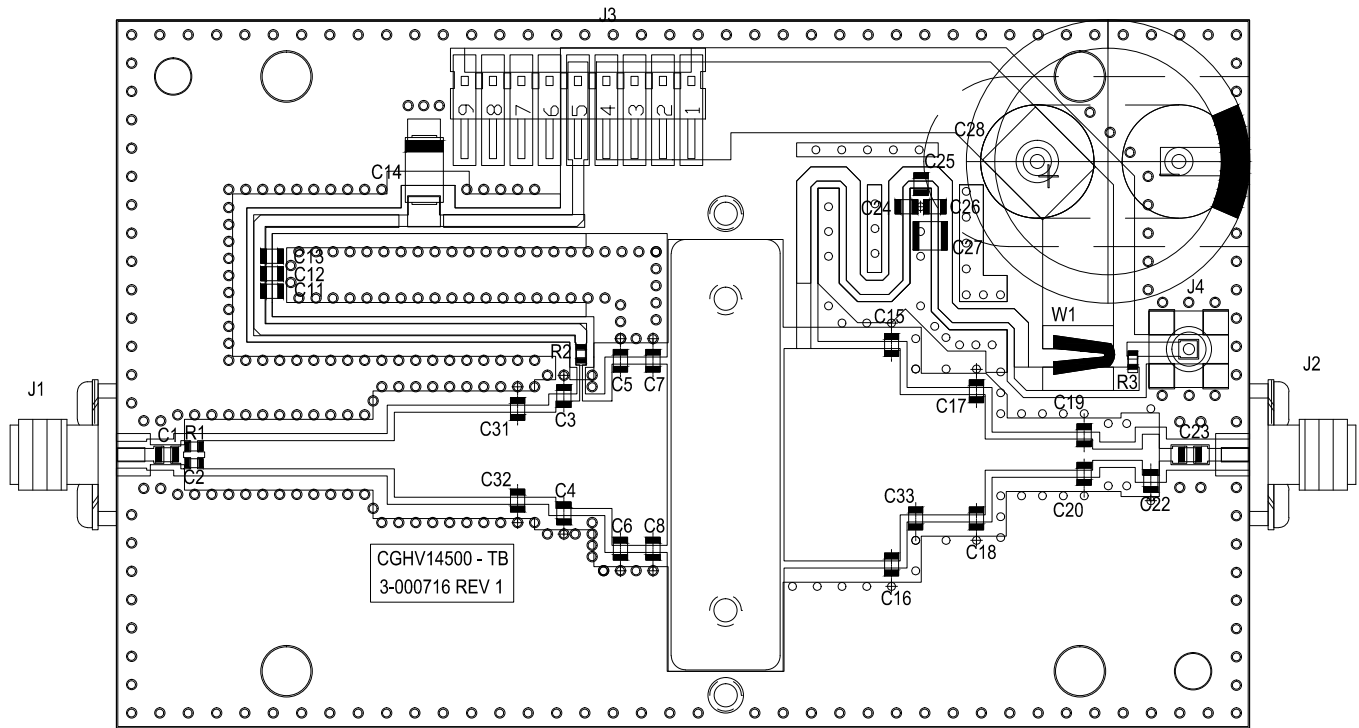
CGHV14500F-AMP Demonstration Amplifier Circuit Bill of Materials

Designator	Description	Qty
R1	RES,1/16W, 0603,1%, 562 ohms	1
R2	RES, 5.1 ohm, +/- 1%, 1/16W,0603	1
R3	RES, 1/16W, 0603,1%, 4.99K ohms	1
C1, C7, C8, C23	CAP, 10pF, +/-0.1pF, 250V, 0805, ATC 600F	4
C2, C15, C16	CAP, 5.6pF, +/-0.1pF, 250V, 0805, ATC 600F	3
C3, C4, C5, C6	CAP, 2.2pF, +/-0.1pF, 250V, 0805, ATC 600F	4
C17, C18	CAP, 2.4pF, +/-0.1pF, 250V, 0805, ATC 600F	2
C19, C20	CAP, 2.0pF, +/-0.1pF, 250V, 0805, ATC 600F	2
C31, C32	CAP, 2.7pF, +/-0.1pF, 250V, 0805, ATC 600F	2
C22, C33	CAP, 1.5pF, +/-0.1pF, 250V, 0805, ATC 600F	2
C11, C24	CAP, 47 pF +/- 5%, 250V, 0805, ATC 600F	2
C12, C25	CAP, 100 pF +/- 5%, 250V, 0805, ATC 600F	2
C13, C26	CAP, 33000pF, 0805,100V, X7R	2
C14	CAP, 10μF, 16V, TANTALUM	1
C27	CAP, 1.0μF, 100V, 10%, X7R, 1210	1
C28	CAP, 3300 μF, +/-20%, 100V, ELECTROLYTIC	1
J1, J2	CONN, SMA, PANEL MOUNT JACK, FL	2
J3	HEADER RT>PLZ .1CEN LK 9POS	1
J4	CONNECTOR ; SMB, Straight, JACK, SMD	1
W1	CABLE, 18 AWG, 4.2	1
	PCB, RO4350B, 0.020" THK, CGHV14500-TB1	1
	BASEPLATE, AL, 4.00 X 2.50 X 0.49, ALTERNATE HOLE PATTERN	1

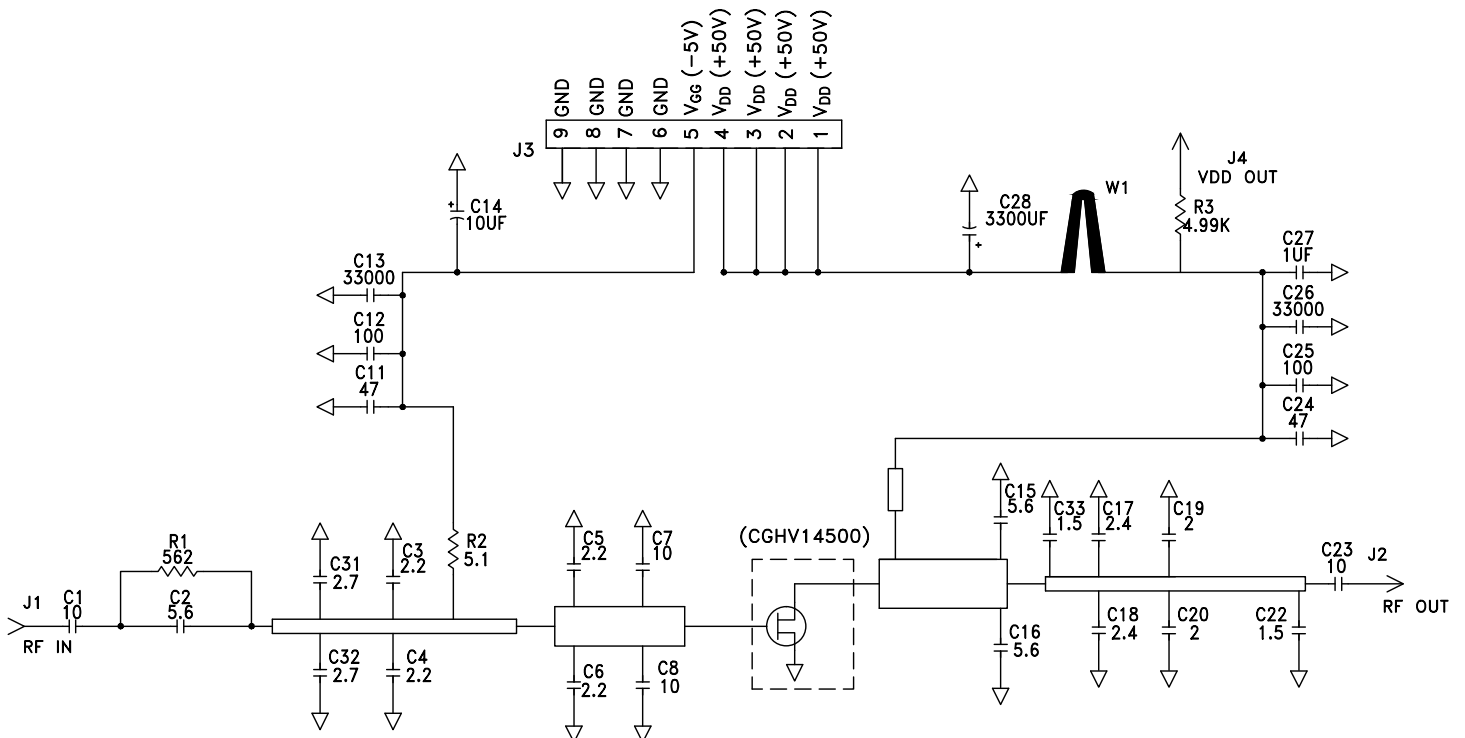
CGHV14500F-AMP2 Demonstration Amplifier Circuit



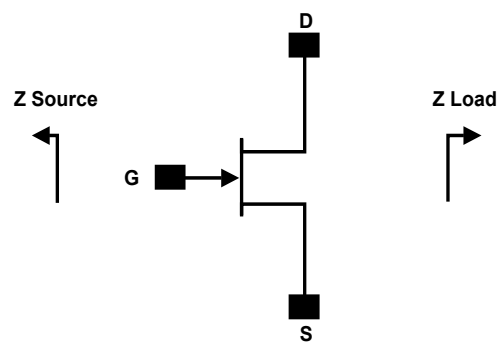
CGHV14500-AMP Demonstration Amplifier Circuit Outline



CGHV14500-AMP Demonstration Amplifier Circuit Schematic



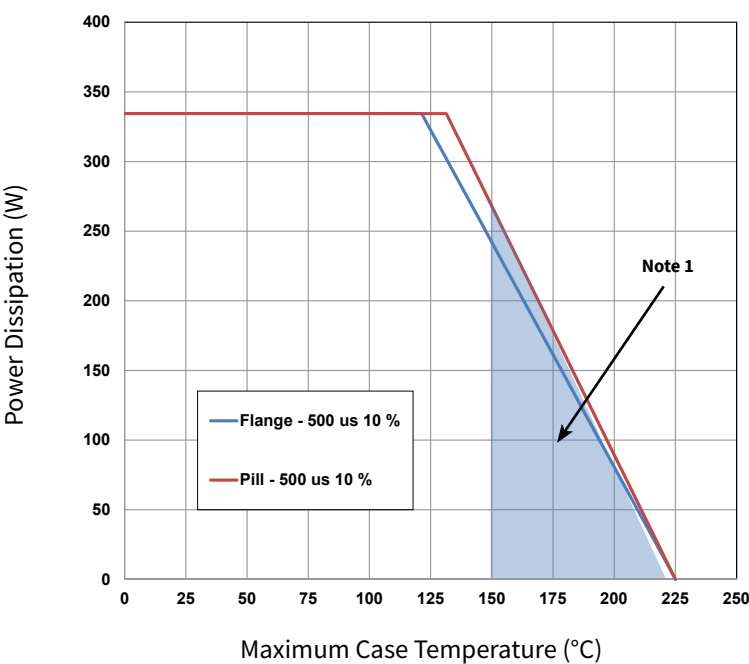
Source and Load Impedances



Frequency	Z Source	Z Load
900	0.3 - j0.3	2.1 + j1.4
1000	0.3 - j0.4	2.0 + j0.7
1100	0.6 - j0.4	1.8 + j0.9
1200	0.8 - j0.7	1.5 + j0.9
1300	1.1 - j0.7	1.3 + j0.7
1400	1.2 - j0.1	1.2 + j0.5
1500	1.8 - j0.1	1.1 + j0.4

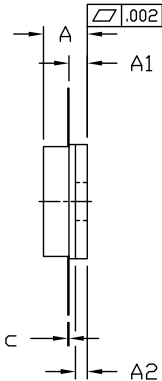
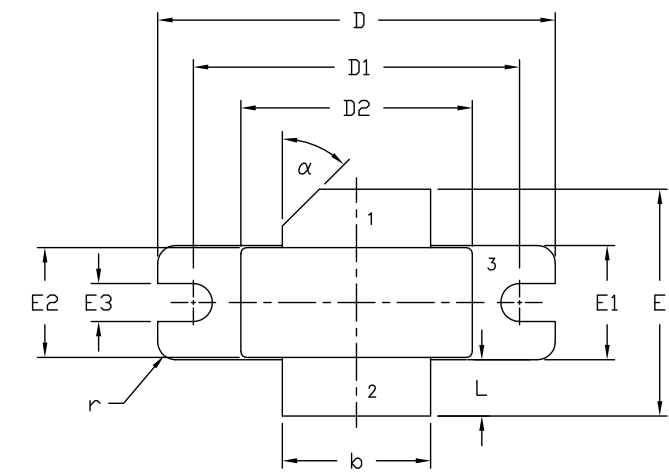
Notes:
¹ $V_{DD} = 50\text{ V}$, $I_{DQ} = 500\text{ mA}$ in the 440117 package.
² Optimized for power gain, P_{SAT} and Drain Efficiency
³ When using this device at low frequency, series resistors should be used to maintain amplifier stability.

CGHV14500 Power Dissipation De-rating Curve



Note:
¹ Area exceeds Maximum Case Operating Temperature (See Page 2)

Product Dimensions CGHV14500F (Package Type — 440117)

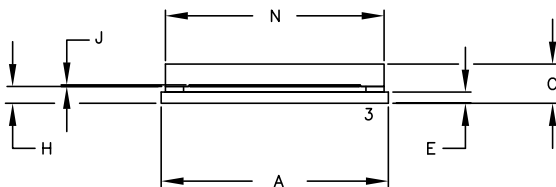
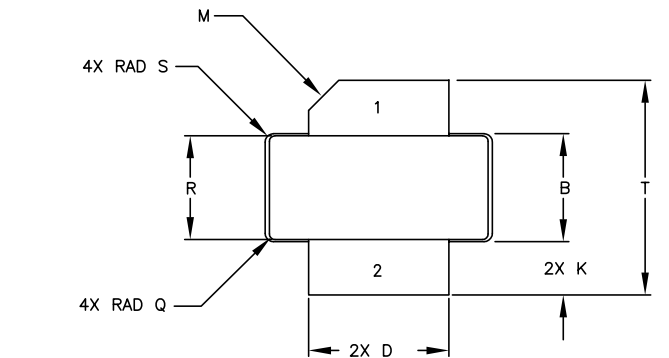


PIN 1. GATE
2. DRAIN
3. SOURCE

- NOTES:
- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M – 1994.
 - 2. CONTROLLING DIMENSION: INCH.
 - 3. ADHESIVE FROM LID MAY EXTEND A MAXIMUM OF 0.020" BEYOND EDGE OF LID.
 - 4. LID MAY BE MISALIGNED TO THE BODY OF PACKAGE BY A MAXIMUM OF 0.008" IN ANY DIRECTION.

DIM	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.138	0.158	3.51	4.01	
A1	0.057	0.067	1.45	1.70	
A2	0.035	0.045	0.89	1.14	
b	0.495	0.505	12.57	12.83	2x
c	0.003	0.006	0.08	0.15	
D	1.335	1.345	33.91	34.16	
D1	1.095	1.105	27.81	28.07	
D2	0.773	0.787	19.63	20.00	
E	0.745	0.785	18.92	19.94	
E1	0.380	0.390	9.65	9.91	
E2	0.365	0.375	9.72	9.53	
E3	0.123	0.133	3.12	3.38	
L	0.170	0.210	4.32	5.33	2x
r	0.06	TYP	0.06	TYP	4x
α	45°	REF	45°	REF	

Product Dimensions CGHV14500P (Package Type — 440133)



STYLE 1:
PIN 1. GATE
2. DRAIN
3. SOURCE

- NOTES:
- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 - 2. CONTROLLING DIMENSION: INCH.
 - 3. ADHESIVE FROM LID MAY EXTEND A MAXIMUM OF 0.020" BEYOND EDGE OF LID.
 - 4. LID MAY BE MISALIGNED TO THE BODY OF PACKAGE BY A MAXIMUM OF 0.008" IN ANY DIRECTION.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.805	0.815	20.45	20.70
B	0.380	0.390	9.65	9.91
C	0.135	0.149	3.43	3.78
D	0.495	0.505	12.57	12.83
E	0.035	0.045	.89	1.14
H	0.057	0.067	1.45	1.70
J	0.003	0.006	.08	.15
K	0.170	0.210	4.32	5.33
M	45°	REF	45°	REF
N	0.773	0.787	19.63	19.99
Q	0.020	REF	0.51	REF
R	0.364	0.374	9.25	9.50
S	0.030	REF	0.76	REF
T	0.745	0.785	18.92	19.94

Part Number System

CGHV14500F

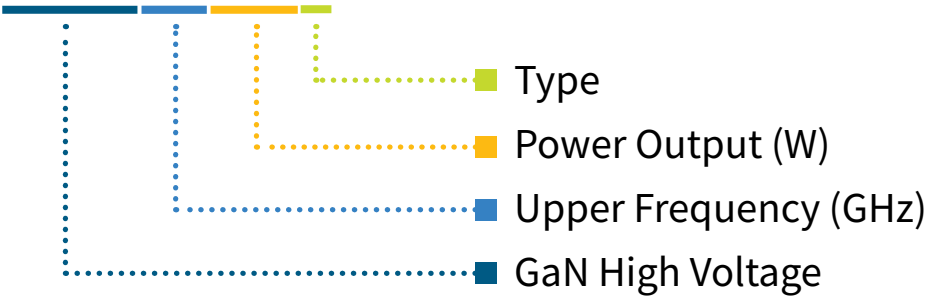


Table 1.

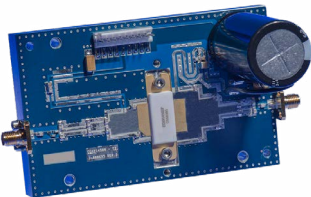
Parameter	Value	Units
Upper Frequency ¹	1.4	GHz
Power Output	250	W
Type	F = Flanged P = Package	—

Note:
¹ Alpha characters used in frequency code indicate a value greater than 9.9 GHz. See Table 2 for value.

Table 2.

Character Code	Code Value
A	0
B	1
C	2
D	3
E	4
F	5
G	6
H	7
J	8
K	9
Examples:	1A = 10.0 GHz 2H = 27.0 GHz

Product Ordering Information

Order Number	Description	Unit of Measure	Image
CGHV14500F	GaN HEMT	Each	
CGHV14500P	GaN HEMT	Each	
CGHV14500F-AMP	Test board with GaN HEMT installed	Each	

Notes & Disclaimer

MACOM Technology Solutions Inc. ("MACOM"). All rights reserved.

These materials are provided in connection with MACOM's products as a service to its customers and may be used for informational purposes only. Except as provided in its Terms and Conditions of Sale or any separate agreement, MACOM assumes no liability or responsibility whatsoever, including for (i) errors or omissions in these materials; (ii) failure to update these materials; or (iii) conflicts or incompatibilities arising from future changes to specifications and product descriptions, which MACOM may make at any time, without notice. These materials grant no license, express or implied, to any intellectual property rights.

THESE MATERIALS ARE PROVIDED "AS IS" WITH NO WARRANTY OR LIABILITY, EXPRESS OR IMPLIED, RELATING TO SALE AND/OR USE OF MACOM PRODUCTS INCLUDING FITNESS FOR A PARTICULAR PURPOSE, MERCHANTABILITY, INFRINGEMENT OF INTELLECTUAL PROPERTY RIGHT, ACCURACY OR COMPLETENESS, OR SPECIAL, INDIRECT, INCIDENTAL, OR CONSEQUENTIAL DAMAGES WHICH MAY RESULT FROM USE OF THESE MATERIALS.

MACOM products are not intended for use in medical, lifesaving or life sustaining applications. MACOM customers using or selling MACOM products for use in such applications do so at their own risk and agree to fully indemnify MACOM for any damages resulting from such improper use or sale.